



TFW 1711

PATENT APPLICATION

IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant(s): Hirokazu IKEDA, et al.
Title : METHOD OF PRODUCING ENANTIOMERIC ISOMER-SEPARATING FILLER


Serial No. : 10/529 698 Group: 1711
Confirmation No.: 2018
Filed : March 29, 2005 Examiner: Unknown
International Application No.: PCT/JP03/12942
International Filing Date : October 9, 2003
Atty. Docket No.: Furuya Case 1419

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

FIRST CLASS MAILING CERTIFICATE

Sir:

I hereby certify that this correspondence is being deposited with the United States Postal Service under 37 CFR 1.8 as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on November 18, 2005.


Terryence F. Chapman

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	Sidney B. Williams, Jr.	Reg. No. 24 949

Correspondence: Information Disclosure Statement dated
November 16, 2005, with enclosures stated thereon

190.05/05



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INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(e)(1) and 1.98, enclosed herewith is a copy of the European Patent Office Search Report for the foreign patent application corresponding to the present application, Form PTO-1449 and the non-U.S. references cited thereon. Copies of cited U.S. references are not submitted in accordance with 37 CFR 1.98(a).

Where necessary, the requirement for a concise explanation of relevance of any enclosed non-English reference is satisfied by the enclosed European Patent Office Search Report. Further comment at this point in time should not be necessary.

Further consideration is respectfully solicited.

Respectfully submitted,



Terryence F. Chapman

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Encl: Copy of European Patent Office Search Report dated
September 6, 2005 (3 pages)
Form PTO-1449 and non-U.S. references cited thereon
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INFORMATION
DISCLOSURE
CITATION

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U.S. PATENT DOCUMENTS

Examiner Initials*	No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA			
	AB			
	AC			
	AD			
	AE			
	AF			
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	AH			
	AI			

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AJ	EP 0 254 811 A	02-03-1988	Raghunathan, et al.	
	AK	EP 1 496 356 A	01-12-2005	Onishi, et al.	
	AL				
	AM				
	AN				

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AO	European Patent Office Search Report dated September 6, 2005 (3 pages)
	AP	
EXAMINER SIGNATURE		DATE CONSIDERED

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